

# SEARCHED

Class	Sub.	Date	Exmr.
435	91.2	8/11/98	J. ✓
	91.1	"	"
	91.52	"	"
428	18	"	"
	41	"	"
	42	"	"
	913	"	"
156	157	"	"
	230	"	"
	236	"	"
	275.5	"	"
	307.1	"	"
	331.3	"	"
	331.6	"	"
	330	"	"
	330.8	"	"
	331.7	"	"
updated search		12/7/98	EC
updated search		6/11/99	EC

## SEARCH NOTES

	Date	Exmr.
STN. possible upper, middle explor	3/12/98	J. ✓
Key used		
solid field material		
even		
cell surface		
photodup with just		
adher		
solid test		
met		

## INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.
435	91.2	6/11/99	EC
435	6	"	"

(RIGHT OUTSIDE)